

Notice of References Cited	Application/Control No. 10/814,597	Applicant(s)/Patent Under Reexamination LEON ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,004,065	12-1999	Higdon et al.	403/384
	B	US-4,630,338	12-1986	Osterland et al.	24/293
	C	US-5,100,273	03-1992	Vassiliou, Eustathios	411/80.1
	D	US-5,641,255	06-1997	Tanaka, Tsutomu	411/48
	E	US-5,774,949	07-1998	Cornell et al.	24/293
	F	US-5,803,532	09-1998	Karuppaswamy et al.	296/187.05
	G	US-6,438,804	08-2002	Romero Magarino, Antonio	24/289
	H	US-6,481,942	11-2002	Tanaka, Tsutomu	411/45
	I	US-6,665,914	12-2003	Ogawa, Atsushi	24/297
	J	US-6,718,599	04-2004	Dickinson et al.	24/295
	K	US-6,827,536	12-2004	Leon et al.	411/61
	L	US-2003/0143053	07-2003	Kanie, Hideki	411/45
	M	US-5,775,860	07-1998	Meyer, Charles	411/46

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/49299	08-2000	WIPO	Leon et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,718,549	02-1998	Noda et al.	411/553
	B	US-4,927,287	05-1990	Ohkawa et al.	403/408.1
	C	US-2,571,394	10-1951	TRAFTON WARREN L	411/112
	D	US-2,303,148	11-1942	TINNERMAN GEORGE A	411/111
	E	US-6,398,473	06-2002	Kraus, Willibald	411/508
	F	US-4,878,791	11-1989	Kurihara et al.	411/55
	G	US-4,007,516	02-1977	Coules, Ronald A.	411/349
	H	US-6,454,507	09-2002	Romero Magarino, Antonio	411/508
	I	US-6,616,479	09-2003	Jones, Dennis B.	439/567
	J	US-6,196,756	03-2001	Leverger, Eric	403/326
	K	US-5,201,623	04-1993	Benedetti et al.	411/48
	L	US-20040223826	11-2004	Leon et al.	411/44
	M	US-5,368,427	11-1994	Pfaffinger, David A.	411/553

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,645,311	02-1972	Tinnerman, George A.	411/173
	B	US-6,353,981	03-2002	Smith, Edward John	24/295
	C	US-6,141,837	11-2000	Wisniewski, David M.	24/295
	D	US-5,011,355	04-1991	Motoshige, Inaba	411/552
	E	US-20040170491	09-2004	Hulin et al.	411/553
	F	US-2001/0041113	11-2001	Antonucci et al.	411/553
	G	US-2001/0036392	11-2001	Reddicliffe, Edward	411/349
	H	US-6,773,215	08-2004	Cuva et al.	411/553
	I	US-6,679,646	01-2004	Quardt et al.	403/348
	J	US-6,540,463	04-2003	Ward, Michael E.	411/173
	K	US-6,267,543	07-2001	David et al.	411/552
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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